

**Notice of References Cited**

Application/Control No.

10/528,157

Applicant(s)/Patent Under  
Reexamination  
MEGED ET AL.

Examiner

David Oveissi

Art Unit

2616

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0026203	02-2003	Manganini et al.	370/221
*	B	US-6,122,250	09-2000	Taniguchi, Atsuki	370/222
*	C	US-7,002,976	02-2006	Dupont, Jean-Lou	370/404
*	D	US-7,177,328	02-2007	Miller, Glen W.	370/503
*	E	US-2004/0109408	06-2004	Mesh et al.	370/222
*	F	US-2005/0041601	02-2005	Kam et al.	370/258
*	G	US-5,570,371	10-1996	Iga, Naoto	370/476
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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